

<b>Notice of References Cited</b>	Application/Control No. 10/604,450		Applicant(s)/Patent Under Reexamination TING ET AL.	
	Examiner Navneet K. Ahluwalia		Art Unit 2166	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,970,489 A	10-1999	Jacobson et al.	707/10
*	B	US-6,144,962 A	11-2000	Weinberg et al.	707/10
*	C	US-6,237,006 B1	05-2001	Weinberg et al.	707/103R
*	D	US-2002/0051020 A1	05-2002	Ferrari et al.	345/854
*	E	US-2003/0097357 A1	05-2003	Ferrari et al.	707/3
*	F	US-2004/0119743 A1	06-2004	Xu, Songwen	345/760
*	G	US-2004/0128615 A1	07-2004	Carmel et al.	715/513
*	H	US-2004/0268296 A1	12-2004	Kayam et al.	717/104
*	I	US-2005/0060647 A1	03-2005	Doan et al.	715/514
*	J	US-2003/0018603 A1	01-2003	Tip et al.	707/1
*	K	US-2005/0055355	03-2005	Murthy et al.	707/100
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.